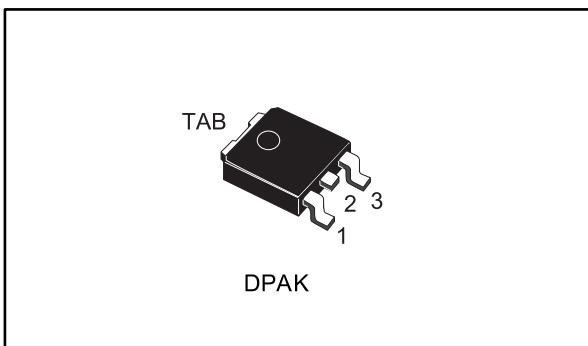
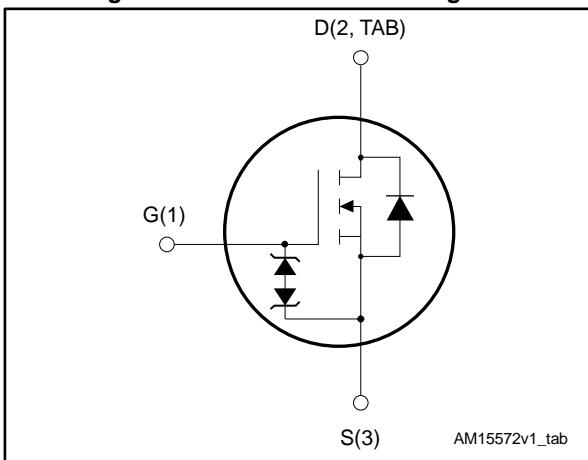


## N-channel 600 V, 0.280 $\Omega$ typ., 12 A MDmesh™ M2 Power MOSFET in a DPAK package

Datasheet - production data



**Figure 1: Internal schematic diagram**



### Features

| Order code | V <sub>DS</sub> | R <sub>DS(on)</sub> max. | I <sub>D</sub> |
|------------|-----------------|--------------------------|----------------|
| STD16N60M2 | 600 V           | 0.320 $\Omega$           | 12 A           |

- Extremely low gate charge
- Excellent output capacitance (C<sub>oss</sub>) profile
- 100% avalanche tested
- Zener-protected

### Applications

- Switching applications

### Description

This device is an N-channel Power MOSFET developed using MDmesh™ M2 technology. Thanks to its strip layout and an improved vertical structure, the device exhibits low on-resistance and optimized switching characteristics, rendering it suitable for the most demanding high efficiency converters.

**Table 1: Device summary**

| Order code | Marking | Package | Packing       |
|------------|---------|---------|---------------|
| STD16N60M2 | 16N60M2 | DPAK    | Tape and reel |

## Contents

|          |  |           |
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# 1 Electrical ratings

Table 2: Absolute maximum ratings

| Symbol         | Parameter   | Value      | Unit             |
|----------------|---|------------|------------------|
| $V_{GS}$       | Gate-source voltage                                     | $\pm 25$   | V                |
| $I_D$          | Drain current (continuous) at $T_C = 25^\circ\text{C}$  | 12         | A                |
| $I_D$          | Drain current (continuous) at $T_C = 100^\circ\text{C}$ | 7.6        | A                |
| $I_{DM}^{(1)}$ | Drain current (pulsed)                                  | 48         | A                |
| $P_{TOT}$      | Total dissipation at $T_C = 25^\circ\text{C}$           | 110        | W                |
| $dv/dt^{(2)}$  | Peak diode recovery voltage slope                       | 15         | V/ns             |
| $dv/dt^{(3)}$  | MOSFET dv/dt ruggedness                                 | 50         | V/ns             |
| $T_{stg}$      | Storage temperature                                     | -55 to 150 | $^\circ\text{C}$ |
| $T_j$          | Max. operating junction temperature                     | 150        |                  |

**Notes:**

(1) Pulse width limited by safe operating area.

(2)  $I_{SD} \leq 12$  A,  $di/dt \leq 400$  A/ $\mu\text{s}$ ;  $V_{DS}$  peak <  $V_{(BR)DSS}$ ,  $V_{DD} = 80\%$   $V_{(BR)DSS}$ .(3)  $V_{DS} \leq 480$  V.

Table 3: Thermal data

| Symbol              | Parameter                             | Value | Unit               |
|---------------------|---------------------------------------|-------|--------------------|
| $R_{thj-case}$      | Thermal resistance junction-case max. | 1.14  | $^\circ\text{C/W}$ |
| $R_{thj-pcb}^{(1)}$ | Thermal resistance junction-pcb max.  | 50    | $^\circ\text{C/W}$ |

**Notes:**(1) When mounted on a 1-inch<sup>2</sup> FR-4, 2 oz Cu board

Table 4: Avalanche characteristics

| Symbol   | Parameter  | Value | Unit |
|----------|--|-------|------|
| $I_{AR}$ | Avalanche current, repetitive or not repetitive (pulse width limited by $T_{jmax}$ )                 | 2.9   | A    |
| $E_{AS}$ | Single pulse avalanche energy (starting $T_j = 25^\circ\text{C}$ , $I_D = I_{AR}$ , $V_{DD} = 50$ V) | 130   | mJ   |

## 2 Electrical characteristics

( $T_C = 25^\circ\text{C}$  unless otherwise specified).

**Table 5: Static**

| Symbol                      | Parameter                         | Test conditions   | Min. | Typ.  | Max.     | Unit          |
|-----------------------------|-----------------------------------|---|------|-------|----------|---------------|
| $V_{(\text{BR})\text{DSS}}$ | Drain-source breakdown voltage    | $V_{GS} = 0 \text{ V}, I_D = 1 \text{ mA}$                              | 600  |       |          | V             |
| $I_{\text{DSS}}$            | Zero gate voltage drain current   | $V_{GS} = 0 \text{ V}, V_{DS} = 600 \text{ V}$                          |      |       | 1        | $\mu\text{A}$ |
|                             |                                   | $V_{GS} = 0 \text{ V}, V_{DS} = 600 \text{ V}, T_C = 125^\circ\text{C}$ |      |       | 100      | $\mu\text{A}$ |
| $I_{GSS}$                   | Gate-body leakage current         | $V_{DS} = 0 \text{ V}, V_{GS} = \pm 25 \text{ V}$                       |      |       | $\pm 10$ | $\mu\text{A}$ |
| $V_{GS(\text{th})}$         | Gate threshold voltage            | $V_{DS} = V_{GS}, I_D = 250 \mu\text{A}$                                | 2    | 3     | 4        | V             |
| $R_{DS(\text{on})}$         | Static drain-source on-resistance | $V_{GS} = 10 \text{ V}, I_D = 6 \text{ A}$                              |      | 0.280 | 0.320    | $\Omega$      |

**Table 6: Dynamic**

| Symbol                      | Parameter                     | Test conditions  | Min. | Typ. | Max. | Unit     |
|-----------------------------|-------------------------------|--|------|------|------|----------|
| $C_{iss}$                   | Input capacitance             | $V_{DS} = 100 \text{ V}, f = 1 \text{ MHz}, V_{GS} = 0 \text{ V}$  | -    | 700  | -    | pF       |
| $C_{oss}$                   | Output capacitance            |  | -    | 38   | -    | pF       |
| $C_{rss}$                   | Reverse transfer capacitance  |  | -    | 1.2  | -    | pF       |
| $C_{oss \text{ eq.}}^{(1)}$ | Equivalent output capacitance | $V_{DS} = 0 \text{ V to } 480 \text{ V}, V_{GS} = 0 \text{ V}$   | -    | 140  | -    | pF       |
| $R_G$                       | Intrinsic gate resistance     | $f = 1 \text{ MHz open drain}$   | -    | 5.3  | -    | $\Omega$ |
| $Q_g$                       | Total gate charge             | $V_{DD} = 480 \text{ V}, I_D = 12 \text{ A}, V_{GS} = 10 \text{ V}$ (see <a href="#">Figure 15: "Gate charge test circuit"</a> ) | -    | 19   | -    | nC       |
| $Q_{gs}$                    | Gate-source charge            |  | -    | 3.3  | -    | nC       |
| $Q_{gd}$                    | Gate-drain charge             |  | -    | 9.5  | -    | nC       |

**Notes:**

<sup>(1)</sup>  $C_{oss \text{ eq.}}$  is defined as a constant equivalent capacitance giving the same charging time as  $C_{oss}$  when  $V_{DS}$  increases from 0 to 80%  $V_{DSS}$ .

**Table 7: Switching times**

| Symbol       | Parameter           | Test conditions  | Min. | Typ. | Max. | Unit |
|--------------|---------------------|--|------|------|------|------|
| $t_{d(on)}$  | Turn-on delay time  | $V_{DD} = 300 \text{ V}, I_D = 6 \text{ A}$  | -    | 10.5 | -    | ns   |
| $t_r$        | Rise time           | $R_G = 4.7 \Omega, V_{GS} = 10 \text{ V}$ (see <a href="#">Figure 14: "Switching times test circuit for resistive load"</a> and <a href="#">Figure 19: "Switching time waveform"</a> ) | -    | 9.5  | -    | ns   |
| $t_{d(off)}$ | Turn-off delay time | $R_G = 4.7 \Omega, V_{GS} = 10 \text{ V}$ (see <a href="#">Figure 14: "Switching times test circuit for resistive load"</a> and <a href="#">Figure 19: "Switching time waveform"</a> ) | -    | 58   | -    | ns   |
| $t_f$        | Fall time           |  | -    | 18.5 | -    | ns   |

Table 8: Source drain diode

| Symbol          | Parameter                     | Test conditions   | Min. | Typ. | Max. | Unit          |
|-----------------|-------------------------------|---|------|------|------|---------------|
| $I_{SD}$        | Source-drain current          |   | -    |      | 12   | A             |
| $I_{SDM}^{(1)}$ | Source-drain current (pulsed) |   | -    |      | 48   | A             |
| $V_{SD}^{(2)}$  | Forward on voltage            | $V_{GS} = 0 \text{ V}$ , $I_{SD} = 12 \text{ A}$  | -    |      | 1.6  | V             |
| $t_{rr}$        | Reverse recovery time         | $I_{SD} = 12 \text{ A}$ ,<br>$di/dt = 100 \text{ A}/\mu\text{s}$ ,<br>$V_{DD} = 60 \text{ V}$ (see <i>Figure 16: "Test circuit for inductive load switching and diode recovery times"</i> )   | -    | 316  |      | ns            |
| $Q_{rr}$        | Reverse recovery charge       |   | -    | 3.25 |      | $\mu\text{C}$ |
| $I_{RRM}$       | Reverse recovery current      |   | -    | 20.5 |      | A             |
| $t_{rr}$        | Reverse recovery time         | $I_{SD} = 12 \text{ A}$ ,<br>$di/dt = 100 \text{ A}/\mu\text{s}$ ,<br>$V_{DD} = 60 \text{ V}$ , $T_j = 150 \text{ }^\circ\text{C}$<br>(see <i>Figure 16: "Test circuit for inductive load switching and diode recovery times"</i> ) | -    | 454  |      | ns            |
| $Q_{rr}$        | Reverse recovery charge       |   | -    | 4.8  |      | $\mu\text{C}$ |
| $I_{RRM}$       | Reverse recovery current      |   | -    | 21   |      | A             |

**Notes:**

(1) Pulse width is limited by safe operating area.

(2) Pulse test: pulse duration = 300  $\mu\text{s}$ , duty cycle 1.5%.

## 2.1

## Electrical characteristics (curves)

Figure 2: Safe operating area

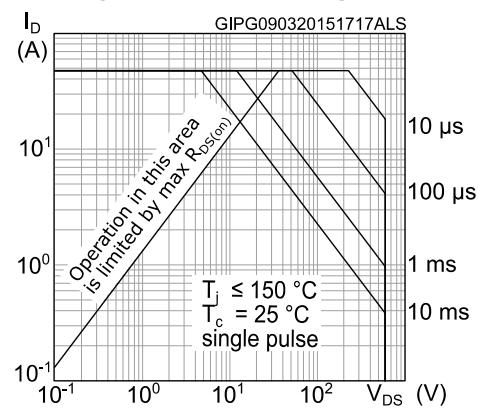


Figure 3: Thermal impedance

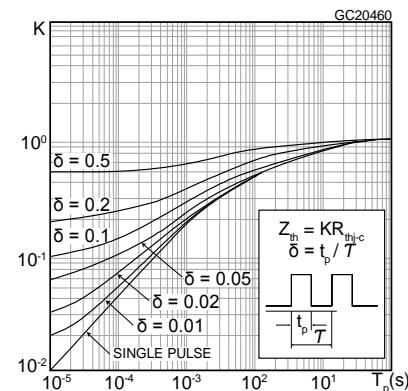


Figure 4: Output characteristics

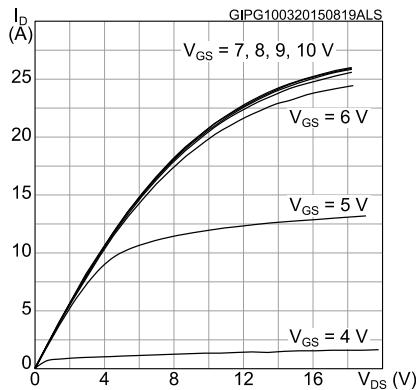


Figure 5: Transfer characteristics

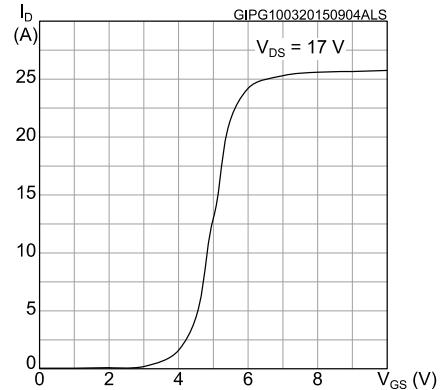


Figure 6: Normalized gate threshold voltage vs. temperature

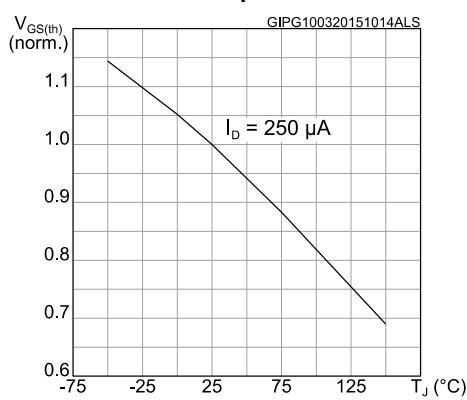
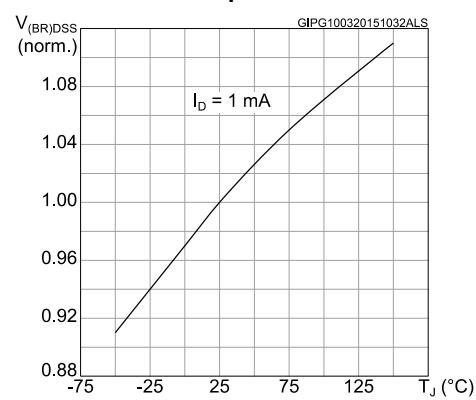
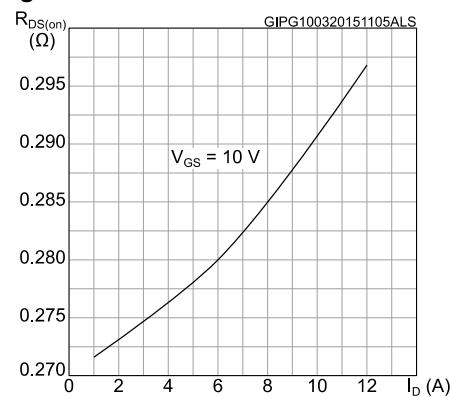
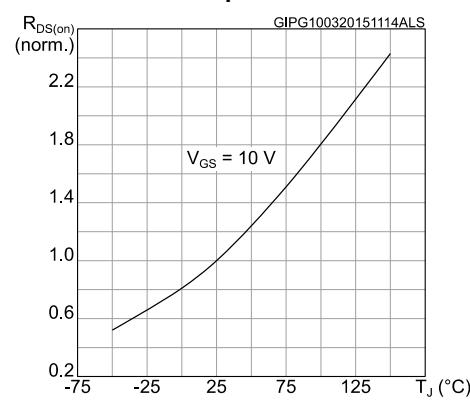
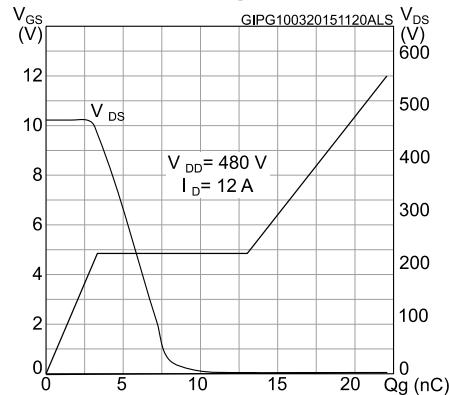
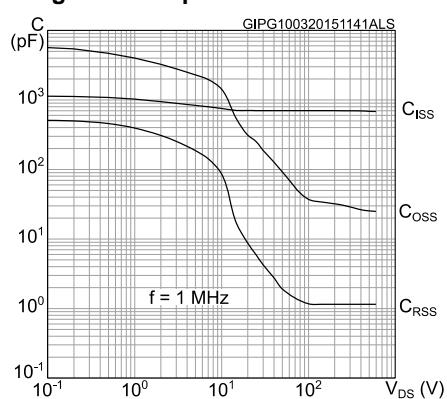
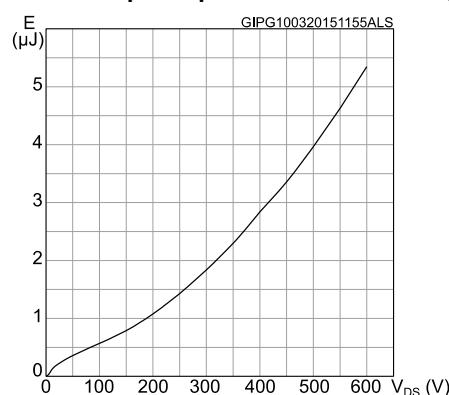
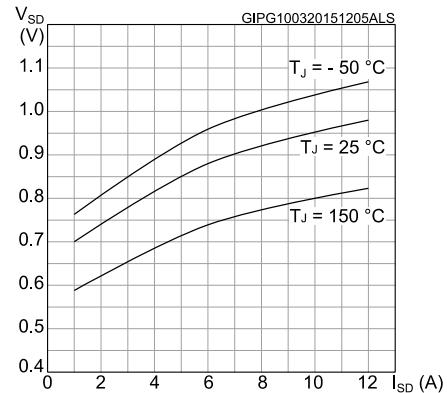


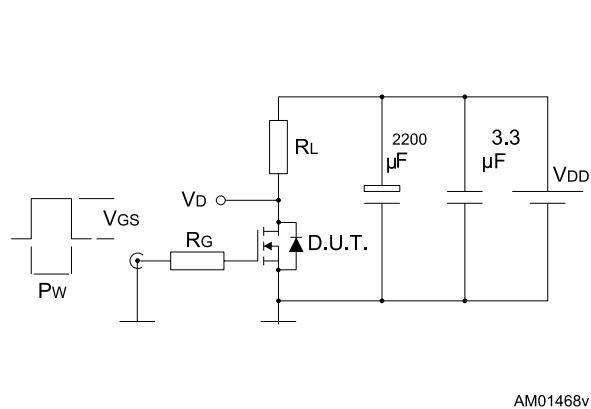
Figure 7: Normalized V(BR)DSS vs. temperature



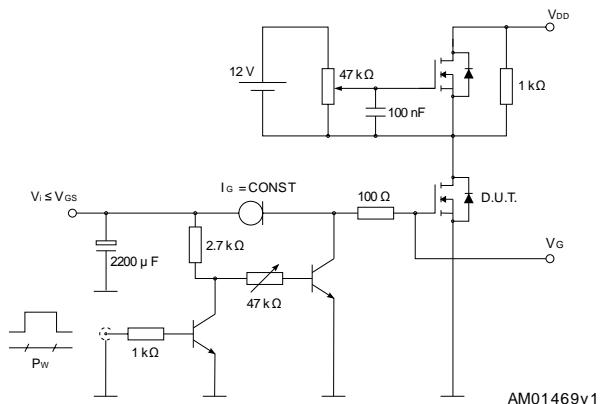
**Figure 8: Static drain-source on-resistance****Figure 9: Normalized on-resistance vs. temperature****Figure 10: Gate charge vs. gate-source voltage****Figure 11: Capacitance variations****Figure 12: Output capacitance stored energy****Figure 13: Source- drain diode forward characteristics**

### 3 Test circuits

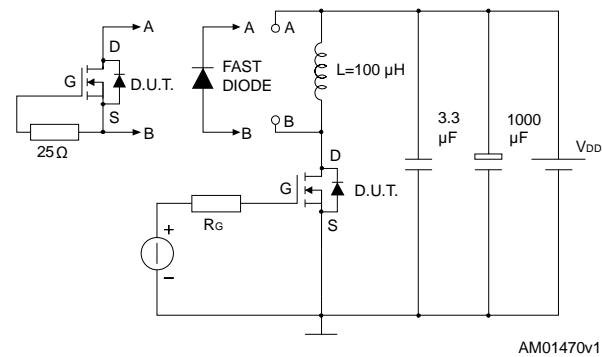
**Figure 14: Switching times test circuit for resistive load**



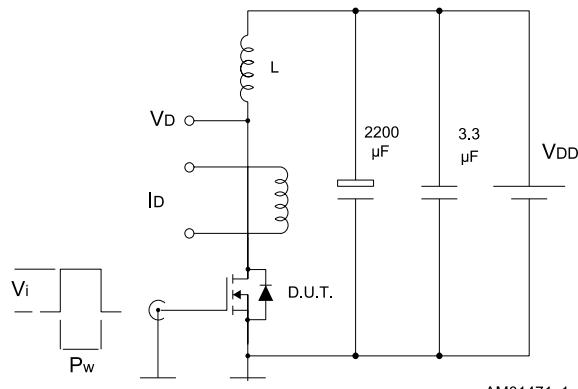
**Figure 15: Gate charge test circuit**



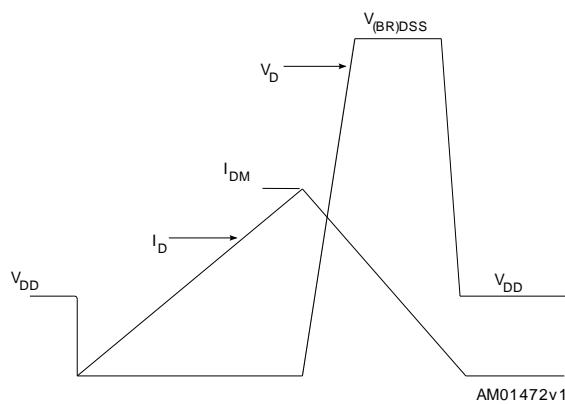
**Figure 16: Test circuit for inductive load switching and diode recovery times**



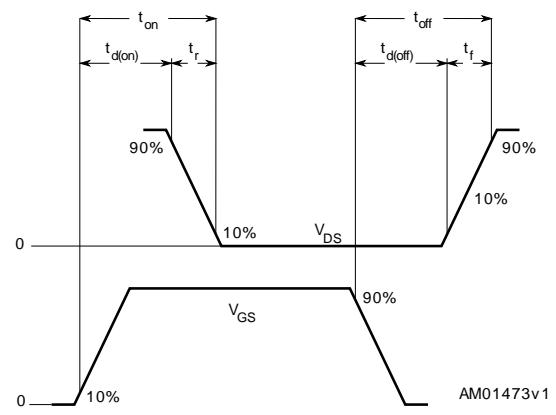
**Figure 17: Unclamped inductive load test circuit**



**Figure 18: Unclamped inductive waveform**



**Figure 19: Switching time waveform**

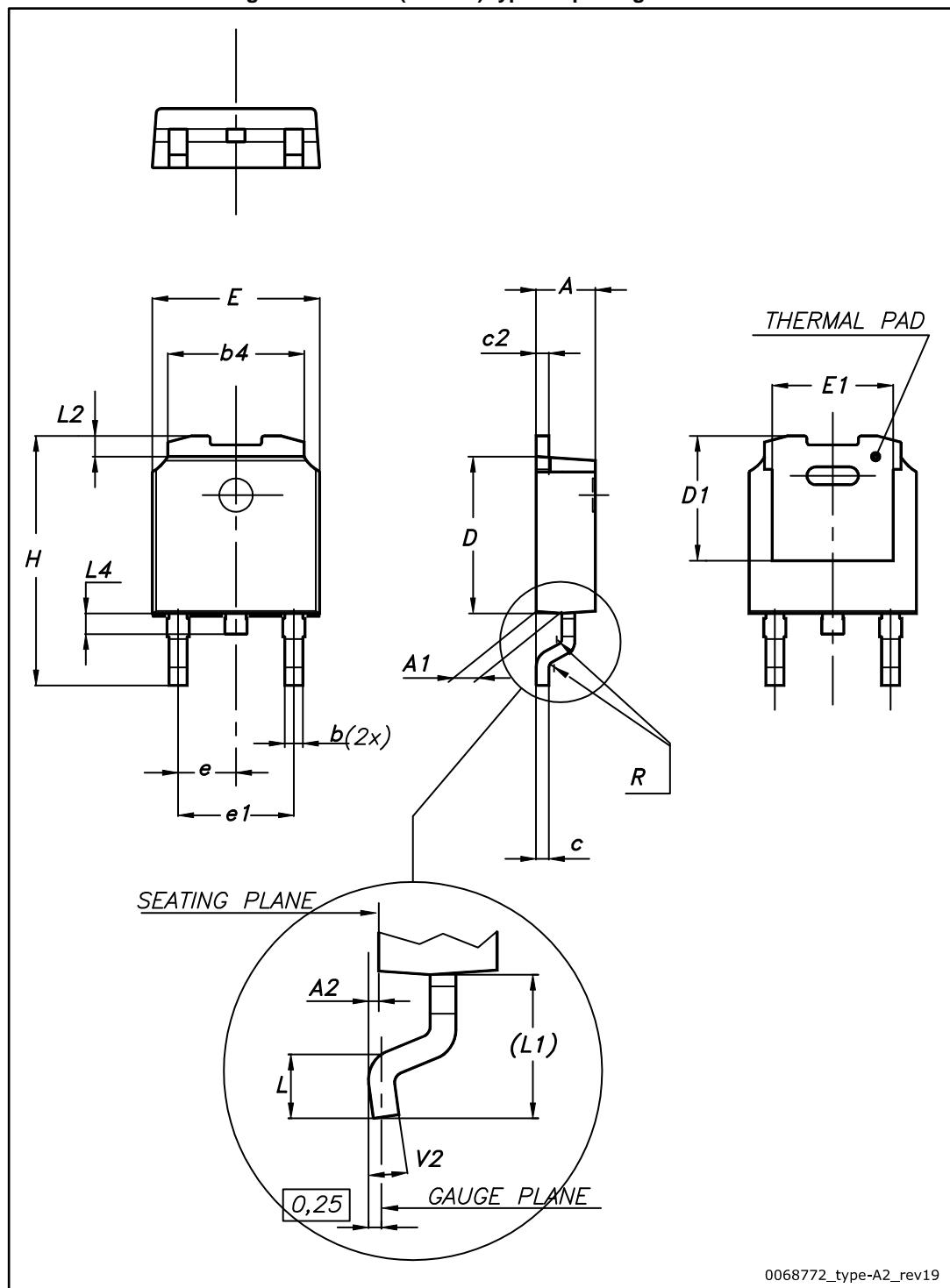


## 4 Package mechanical data

In order to meet environmental requirements, ST offers these devices in different grades of ECOPACK® packages, depending on their level of environmental compliance. ECOPACK® specifications, grade definitions and product status are available at: [www.st.com](http://www.st.com).  
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## 4.1 DPAK (TO-252) type A2 package information

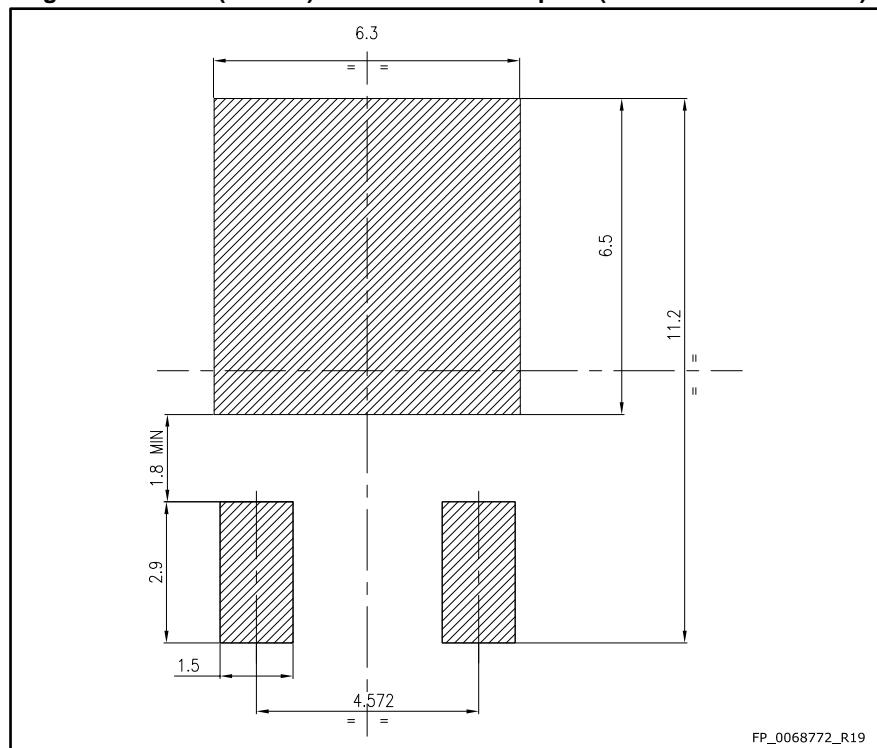
Figure 20: DPAK (TO-252) type A2 package outline



**Table 9: DPAK (TO-252) type A2 mechanical data**

| Dim. | mm   |      |       |
|------|------|------|-------|
|      | Min. | Typ. | Max.  |
| A    | 2.20 |      | 2.40  |
| A1   | 0.90 |      | 1.10  |
| A2   | 0.03 |      | 0.23  |
| b    | 0.64 |      | 0.90  |
| b4   | 5.20 |      | 5.40  |
| c    | 0.45 |      | 0.60  |
| c2   | 0.48 |      | 0.60  |
| D    | 6.00 |      | 6.20  |
| D1   | 4.95 | 5.10 | 5.25  |
| E    | 6.40 |      | 6.60  |
| E1   | 5.10 | 5.20 | 5.30  |
| e    | 2.16 | 2.28 | 2.40  |
| e1   | 4.40 |      | 4.60  |
| H    | 9.35 |      | 10.10 |
| L    | 1.00 |      | 1.50  |
| L1   | 2.60 | 2.80 | 3.00  |
| L2   | 0.65 | 0.80 | 0.95  |
| L4   | 0.60 |      | 1.00  |
| R    |      | 0.20 |       |
| V2   | 0°   |      | 8°    |

Figure 21: DPAK (TO-252) recommended footprint (dimensions are in mm)



FP\_0068772\_R19

## 4.2 Packing information

Figure 22: Tape for DPAK (TO-252)

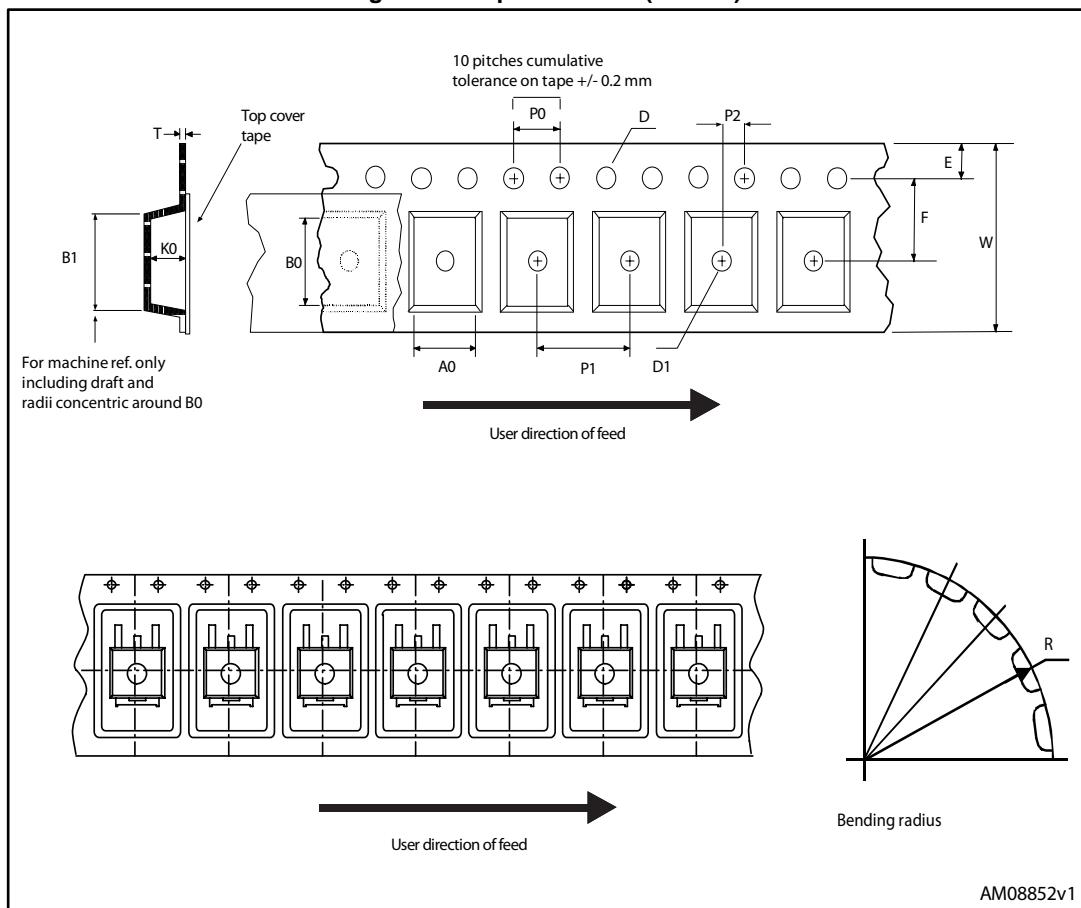


Figure 23: Reel for DPAK (TO-252)

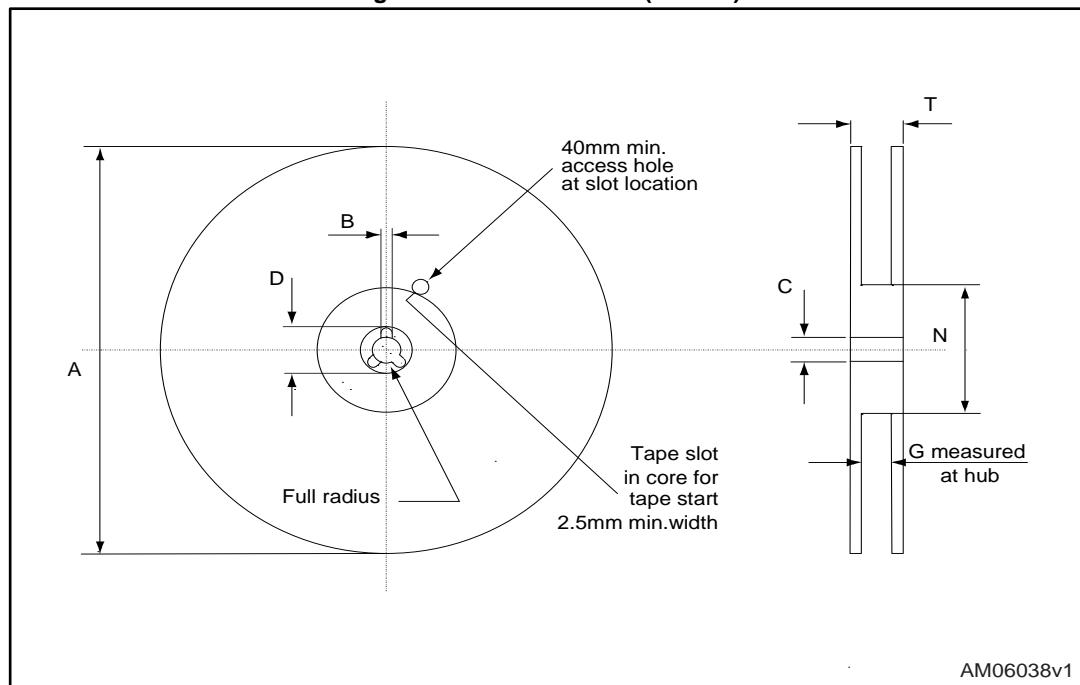


Table 10: DPAK (TO-252) tape and reel mechanical data

| Dim. | Tape |      | Reel      |      |      |
|------|------|------|-----------|------|------|
|      | mm   |      | Dim.      | mm   |      |
|      | Min. | Max. |           | Min. | Max. |
| A0   | 6.8  | 7    | A         |      | 330  |
| B0   | 10.4 | 10.6 | B         | 1.5  |      |
| B1   |      | 12.1 | C         | 12.8 | 13.2 |
| D    | 1.5  | 1.6  | D         | 20.2 |      |
| D1   | 1.5  |      | G         | 16.4 | 18.4 |
| E    | 1.65 | 1.85 | N         | 50   |      |
| F    | 7.4  | 7.6  | T         |      | 22.4 |
| K0   | 2.55 | 2.75 |           |      |      |
| P0   | 3.9  | 4.1  | Base qty. |      | 2500 |
| P1   | 7.9  | 8.1  | Bulk qty. |      | 2500 |
| P2   | 1.9  | 2.1  |           |      |      |
| R    | 40   |      |           |      |      |
| T    | 0.25 | 0.35 |           |      |      |
| W    | 15.7 | 16.3 |           |      |      |

## 5 Revision history

**Table 11: Document revision history**

| Date        | Revision | Changes   |
|-------------|----------|---|
| 26-Nov-2014 | 1        | First release.  |
| 24-Mar-2015 | 2        | <p>Text edits throughout document</p> <p>On cover page: updated cover page title description, updated features table.</p> <p>In Section 1, Electrical ratings: updated "Avalanche characteristics" table</p> <p>In Section 2, Electrical characteristics: renamed "On/off states" table to "Static" and updated table</p> <p>In Section 2, Electrical characteristics: updated tables "Dynamic", "Switching times" and "Source-drain diode"</p> <p>Added Section 2.1, Electrical characteristics (curves)</p> <p>Updated 4.1, DPAK (TO-252) type A2 package information</p> |

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